

• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . It is suitable for automotive application.

• Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- BLDC Motor driver
- DC-DC
- Load Switch

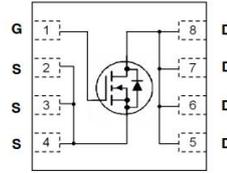
• Ordering Information:

Part NO.	ZMSA020N10HG
Marking	ZMS020N10H
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2500

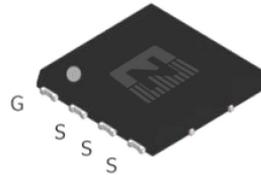
• Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		100	V
Gate-Source Voltage	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	206	A
	$I_D$	$T_C=75^\circ\text{C}$	169	A
	$I_D$	$T_C=100^\circ\text{C}$	146	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ;	824	A
Total Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	214	W
Total Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	4.3	W
Operating Junction Temperature	$T_J$		-55 to +175	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to +175	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	L=0.1mH, VGS=10V, Rg=25 $\Omega$ ,	423	mJ
		L=0.5mH, VGS=10V, Rg=25 $\Omega$ ,	762	mJ
ESD Level (HBM)	CLASS 2			

• Product Summary



$V_{DS} = 100\text{V}$   
 $R_{DS(ON)} = 2\text{m}\Omega$   
 $I_D = 206\text{A}$



DFN8\*8



**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$		-	0.7	$^{\circ}C/W$
Thermal resistance, junction-ambient	$R_{thJA\ominus}$		-	35	$^{\circ}C/W$
Soldering temperature (total time<10s)	$T_{sold}$		-	260	$^{\circ}C$

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	100			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2	2.7	4	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=100V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=40A$		2	2.5	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{GS}=5V, I_{SD}=5A$		30		S
Diode Forward Voltage	$V_{FSD}$	$V_{GS}=0V, I_{SD}=40A$			1.3	V

**•Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$f=1MHz, V_{DS}=25V$	-	6012	-	pF
Output capacitance	$C_{oss}$		-	3235	-	
Reverse transfer capacitance	$C_{rss}$		-	312	-	
Gate Resistance	$R_g$	$f=1MHz$	-	1.6		$\Omega$
Total gate charge	$Q_g$	$V_{DD}=15V, I_D=40A, V_{GS}=10V$	-	93	-	nC
Gate - Source charge	$Q_{gs}$		-	22	-	
Gate - Drain charge	$Q_{gd}$		-	19	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=20A$	-	31	-	ns
Turn-ON Rise time	$t_r$		-	20	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	60	-	ns
Turn-Off Fall time	$t_f$		-	25	-	ns
Reverse Recovery Time	$t_{rr}$	$V_{DD}=20V, di_S/dt=100A/\mu s, I_S=20A$	-	46	-	ns
Reverse Recovery Charge	$Q_{rr}$		-	42	-	nC

Fig.1 Gate-Charge Characteristics

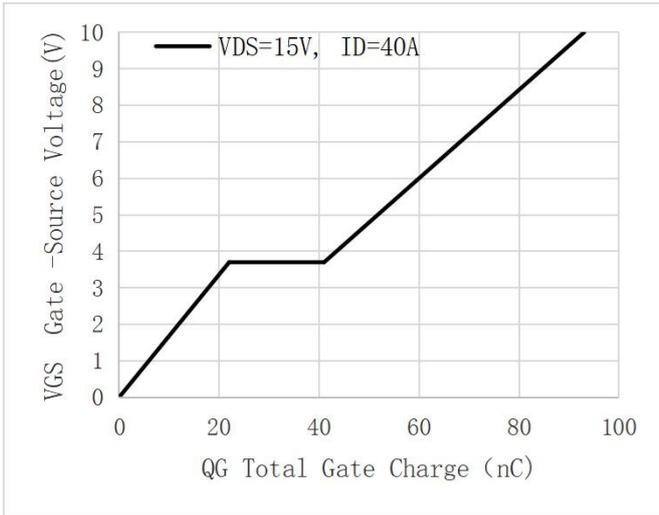


Fig.2 Capacitance Characteristics

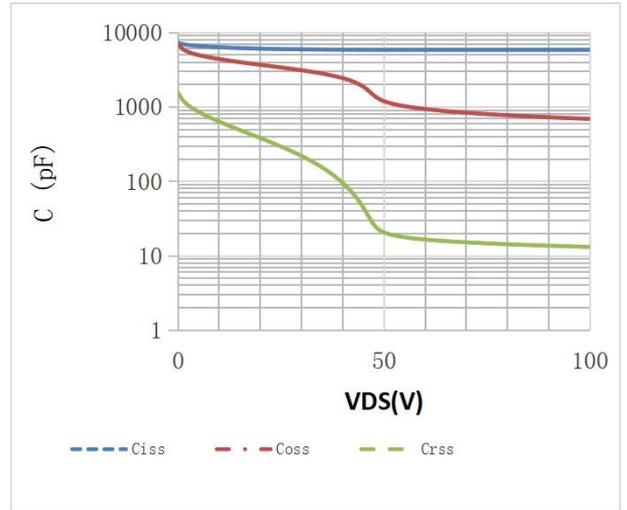


Fig.3 Power Dissipation

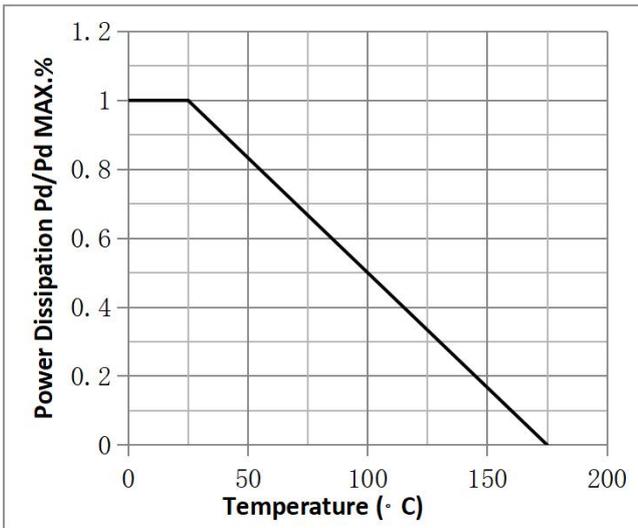


Fig.4 Typical output Characteristics

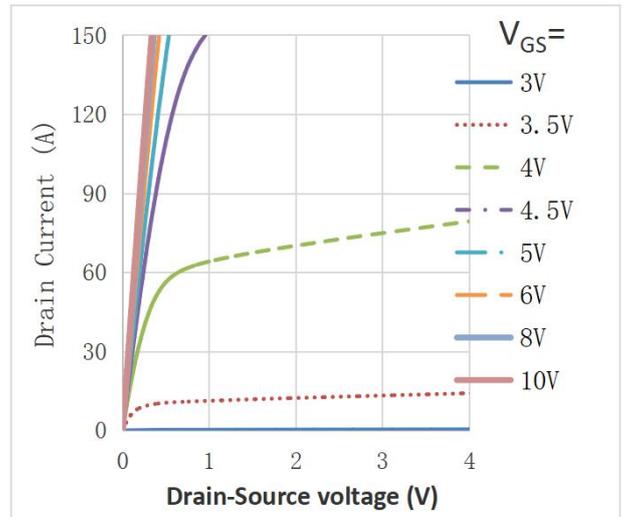


Fig.5 Threshold Voltage V.S Junction Temperature

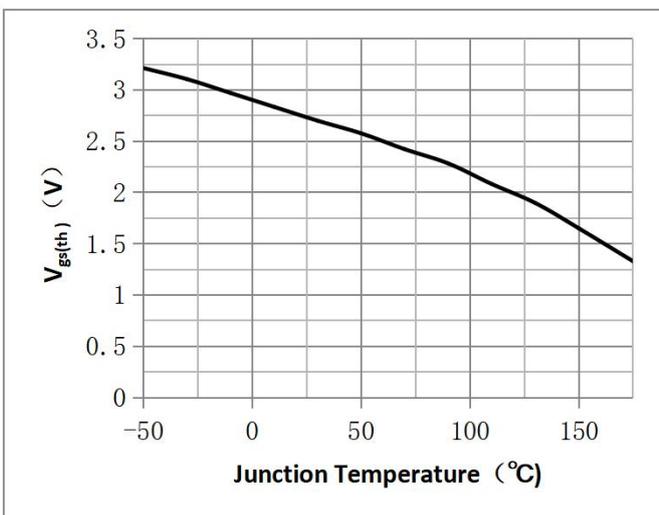


Fig.6 Resistance V.S Drain Current

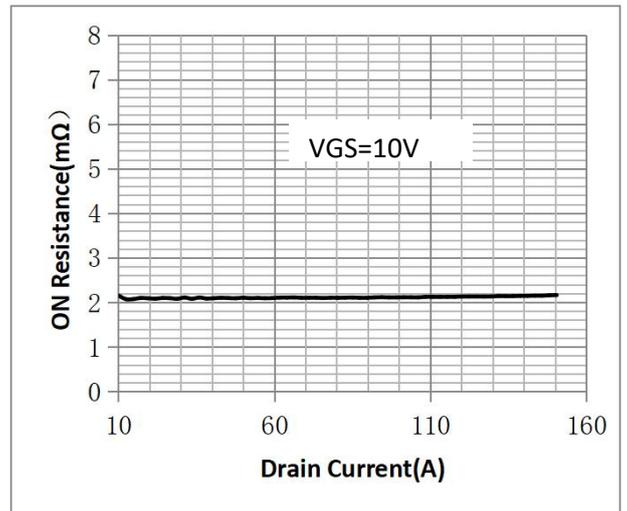


Fig.7 On-Resistance VS Gate Source Voltage

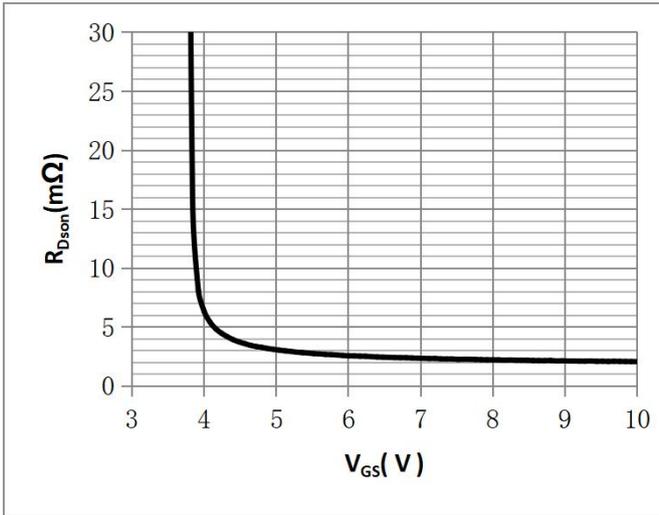


Fig.8 On-Resistance V.S Junction Temperature

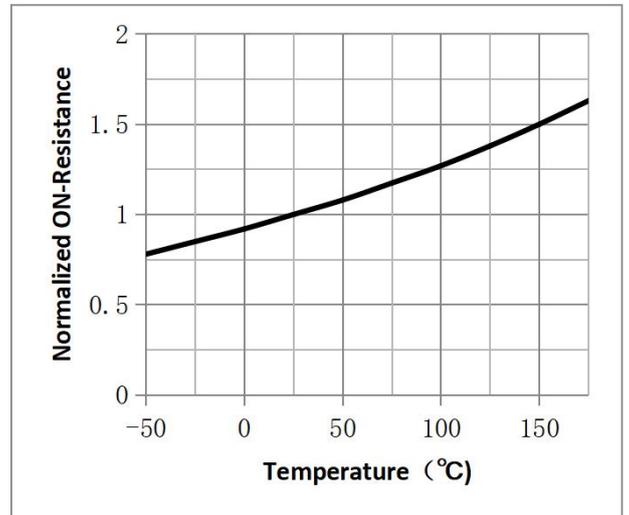


Figure 9. Diode Forward Voltage vs. Current

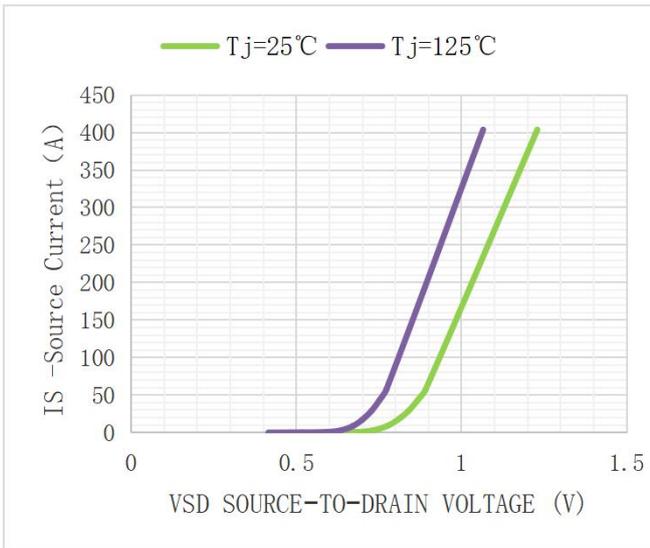


Figure 10. Transfer Characteristics

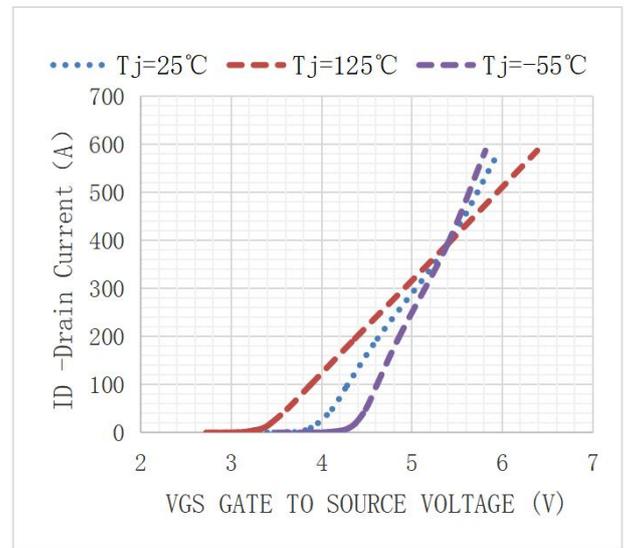


Fig.11 SOA Maximum Safe Operating Area

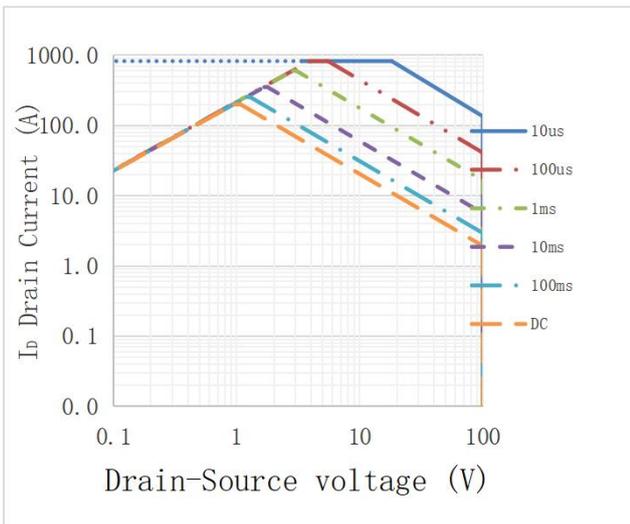
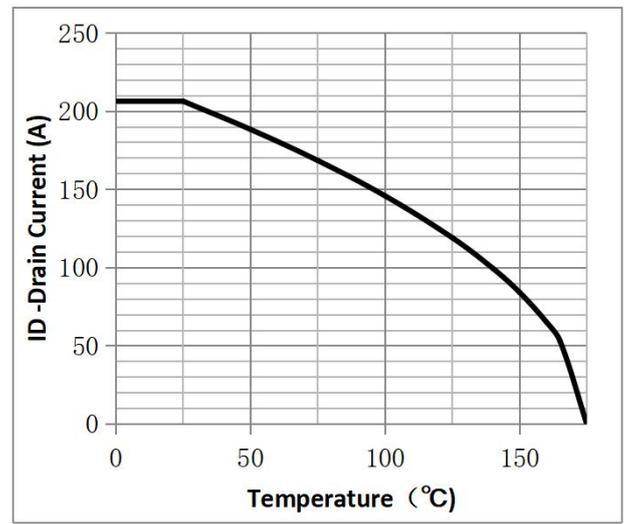
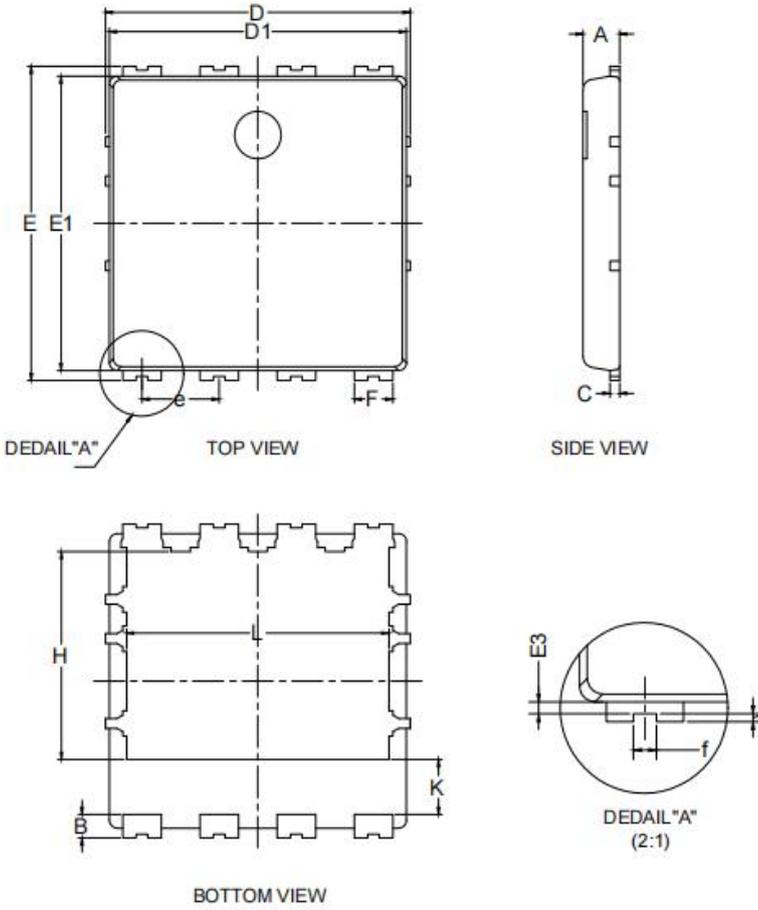


Fig.12 ID vs. Junction Temperature



•DFN8\*8 Package Outline



MILLIMETERS			
DIM	MIN	TYP	MAX
A	0.90	0.95	1.00
B	0.50	0.60	0.70
C	0.254TYP		
D	7.80	7.90	8.00
D1	7.60	7.70	7.80
E	7.90	8.00	8.10
E1	7.40	7.50	7.60
e	2.00TYP		
F	1.00TYP		
H	5.15	5.30	5.40
L	6.60	6.80	6.90
K	1.20	—	—
E2	0.04	0.10	0.16
E3	0.10	0.15	0.20
f	0.25	0.30	0.35

**Note:**

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=10V$ .

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Revision History

Version	Date	Change
A	2024-9-23	New